

### **MOSFET**

### StrongIRFET™2 Power-Transistor, 60 V

### **Features**

- Optimized for wide range of applications
- N-channel, normal level
- 100% avalanche tested
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21

### **Product validation**

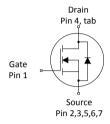
Qualified according to JEDEC Standard

Table 1 Key Performance Parameters

Parameter	Value	Unit				
$V_{ m DS}$	60	V				
$R_{\mathrm{DS(on),max}}$	1.2	mΩ				
I <sub>D</sub>	288	А				
Q <sub>oss</sub>	153	nC				
Q <sub>G</sub> (0V10V)	155	nC				











Type/Ordering Code	Package	Marking	Related Links
IPF012N06NF2S	PG-TO263-7	012N06NS	-

### **Public**

# StrongIRFET™2 Power-Transistor, 60 V IPF012N06NF2S



## **Table of Contents**

Description	1
Maximum ratings	3
Thermal characteristics	4
Electrical characteristics	5
Electrical characteristics diagrams	7
Package Outlines	11
Revision History	12
Trademarks	12
Disclaimer	12



## 1 Maximum ratings

at  $T_{\Delta}$ =25 °C, unless otherwise specified

### Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Nieto/Tost Condition	
raiailietei	Syllibot	Min.	Тур.	Max.	Offic	Note/ Test Condition	
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	-	-	288 221 41	А	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25°C, $R_{\rm THJA}$ =40°C/W <sup>2)</sup>	
Pulsed drain current <sup>3)</sup>	I <sub>D,pulse</sub>	-	-	1152	А	T <sub>A</sub> =25 °C	
Avalanche energy, single pulse <sup>4)</sup>	E <sub>AS</sub>	-	-	727	mJ	$I_{\rm D}$ =100A, $R_{\rm GS}$ =25 $\Omega$	
Gate source voltage	$V_{GS}$	-20	-	20	V	-	
Power dissipation	$P_{tot}$	_	-	294 3.8	W	$T_{\rm C}$ =25 °C $T_{\rm A}$ =25 °C, $R_{\rm THJA}$ =40 °C/W <sup>2)</sup>	
Operating and storage temperature	$T_{\rm j}$ , $T_{\rm stg}$	-55	-	175	°C	-	

<sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions

Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^2$  (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.

<sup>3)</sup> See Diagram 3 for more detailed information

<sup>4)</sup> See Diagram 13 for more detailed information



## 2 Thermal characteristics

### Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Мах.	Offic	Note/ Test Condition	
Thermal resistance, junction - case	$R_{thJC}$	-	-	0.51	°C/W	-	
Thermal resistance, junction - ambient, 6 cm <sup>2</sup> cooling area <sup>5)</sup>	$R_{thJA}$	-	-	40	°C/W	-	
Thermal resistance, junction - ambient, minimal footprint	$R_{thJA}$	-	-	62	°C/W	-	

Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^2$  (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.



### 3 Electrical characteristics

at  $T_i$ =25 °C, unless otherwise specified

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Nate/Test Condition	
raiailletei	Syllibol	Min.	Тур.	Мах.	Offic	Note/ Test Condition	
Drain-source breakdown voltage	$V_{(BR)DSS}$	60	-	-	V	$V_{\rm GS}$ =0 V, $I_{\rm D}$ =1 mA	
Gate threshold voltage	$V_{\rm GS(th)}$	2.1	2.8	3.3	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 186 \mu{\rm A}$	
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.5 10	1 100	μΑ	$V_{\rm DS}$ =60 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C $V_{\rm DS}$ =60 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =125 °C	
Gate-source leakage current	$I_{GSS}$	-	10	100	nA	$V_{\rm GS}$ =20 V, $V_{\rm DS}$ =0 V	
Drain-source on-state resistance	$R_{\mathrm{DS(on)}}$	-	1.07 1.36	1.20 1.9	mΩ	$V_{GS}$ =10 V, $I_{D}$ =100 A $V_{GS}$ =6 V, $I_{D}$ =50 A	
Gate resistance	$R_{G}$	-	2.7	-	Ω	-	
Transconductance <sup>6)</sup>	$g_{fs}$	130	-	-	S	$ V_{\rm DS}  \ge 2 I_{\rm D} R_{\rm DS(on)max}, I_{\rm D} = 100 \text{ A}$	

<sup>6)</sup> Defined by design. Not subject to production test.

Table 5 Dynamic characteristics

Darameter	Symbol		Values			Nato/Task Condition
Parameter	Syllibol	Min.	Тур.	Мах.	Unit	Note/ Test Condition
Input capacitance	$C_{\rm iss}$	-	10500	-	pF	$V_{GS}$ =0 V, $V_{DS}$ =30 V, $f$ =1 MHz
Output capacitance	$C_{\rm oss}$	-	2190	-	pF	$V_{GS}$ =0 V, $V_{DS}$ =30 V, $f$ =1 MHz
Reverse transfer capacitance	C <sub>rss</sub>	-	75	-	pF	$V_{GS}$ =0 V, $V_{DS}$ =30 V, $f$ =1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	27	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Rise time	$t_{\rm r}$	-	34	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Turn-off delay time	$t_{\sf d(off)}$	-	65	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Fall time	$t_{f}$	-	27	-	ns	$V_{\rm DD}$ =30 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =100 A, $R_{\rm G,ext}$ =1.6 $\Omega$

Table 6 Gate charge characteristics 7)

Parameter	Symbol	Values			Unit	Note/ Test Condition
raiailietei	Syllibot	Min.	Тур.	Мах.	Onic	Note/ Test Condition
Gate to source charge	$Q_{ m gs}$	-	46	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V
Gate charge at threshold	$Q_{\mathrm{g(th)}}$	-	29	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V
Gate to drain charge	$Q_{ m gd}$	-	28	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V
Switching charge	$Q_{sw}$	-	45	-	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V
Gate charge total <sup>8)</sup>	$Q_{\mathrm{g}}$	-	155	233	nC	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V



## Table 6 Gate charge characteristics 7)

Parameter	Symbol	Values			Linit	Note/ Test Condition	
raiailletei	Symbol	Min.	Тур.	Мах.	Unit	Note/ rest Condition	
Gate plateau voltage	$V_{ m plateau}$	-	4.4	-	V	$V_{\rm DD}$ =30 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V	
Gate charge total, sync. FET	$Q_{\rm g(sync)}$	-	144	-	nC	$V_{\rm DS}$ =0.1 V, $V_{\rm GS}$ =0 to 10 V	
Output charge	Q <sub>oss</sub>	-	153	-	nC	V <sub>DS</sub> =30 V, V <sub>GS</sub> =0 V	

 $<sup>^{7)} \;\;</sup>$  See "Gate charge waveforms" for parameter definition

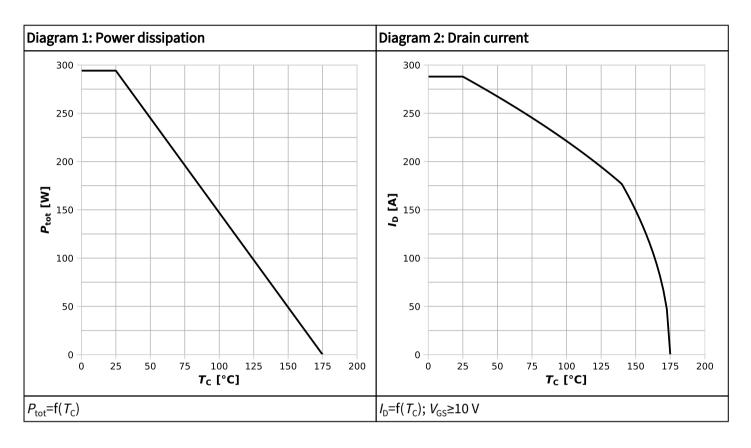
### Table 7 Reverse diode

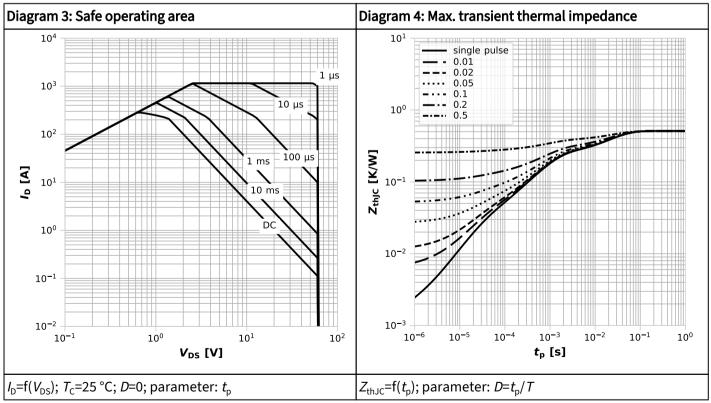
Parameter	Symbol	Values			Unit	Note/ Test Condition	
raiailletei	Symbol	Min.	Тур.	Мах.	Offic	Note/ Test Condition	
Diode continuous forward current	$I_{S}$	-	-	216	А	<i>T</i> <sub>C</sub> =25 °C	
Diode pulse current	I <sub>S,pulse</sub>	-	-	1152	А	<i>T</i> <sub>C</sub> =25 °C	
Diode forward voltage	$V_{\rm SD}$	-	0.86	1	V	$V_{\rm GS}$ =0 V, $I_{\rm F}$ =100 A, $T_{\rm j}$ =25 °C	
Reverse recovery time	$t_{\rm rr}$	-	51	-	ns	$V_R$ =30 V, $I_F$ =100 A, d $I_F$ /d $t$ =100 A/ $\mu$ s	
Reverse recovery charge	$Q_{\rm rr}$	-	63	-	nC	$V_R$ =30 V, $I_F$ =100 A, d $i_F$ /d $t$ =100 A/ $\mu$ s	
Reverse recovery time	$t_{\rm rr}$	-	39	-	ns	$V_R$ =30 V, $I_F$ =100 A, d $i_F$ /d $t$ =500 A/ $\mu$ s	
Reverse recovery charge	$Q_{\rm rr}$	-	210	-	nC	$V_R$ =30 V, $I_F$ =100 A, d $i_F$ /d $t$ =500 A/ $\mu$ s	

<sup>8)</sup> Defined by design. Not subject to production test.

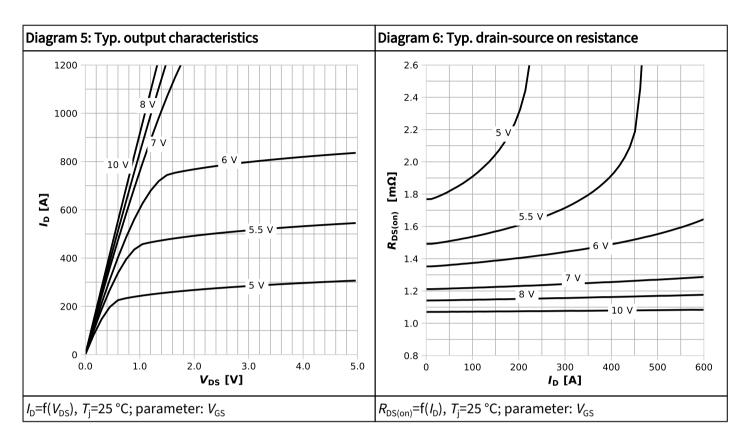


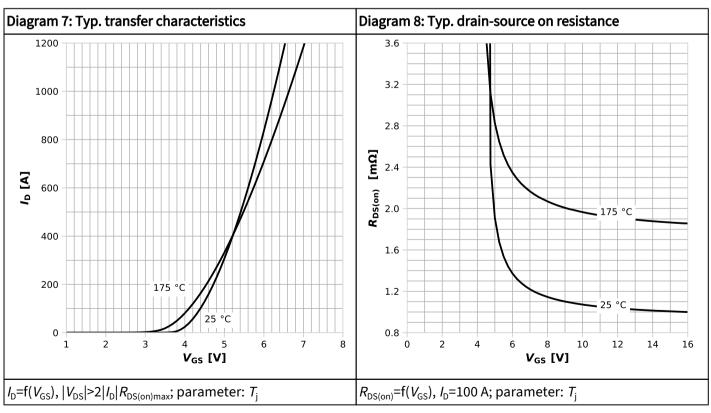
## 4 Electrical characteristics diagrams



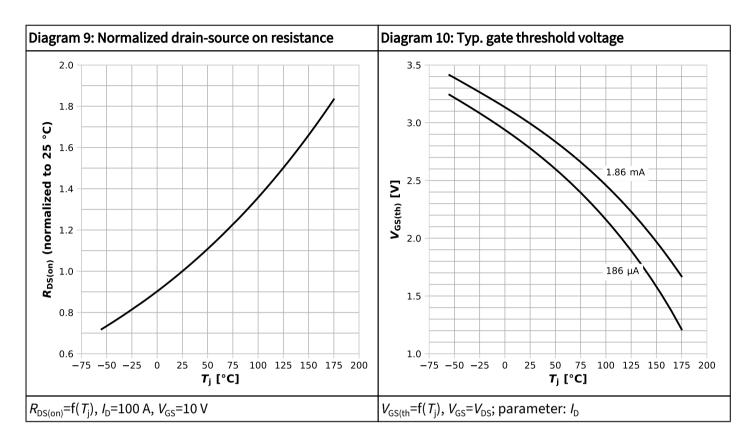


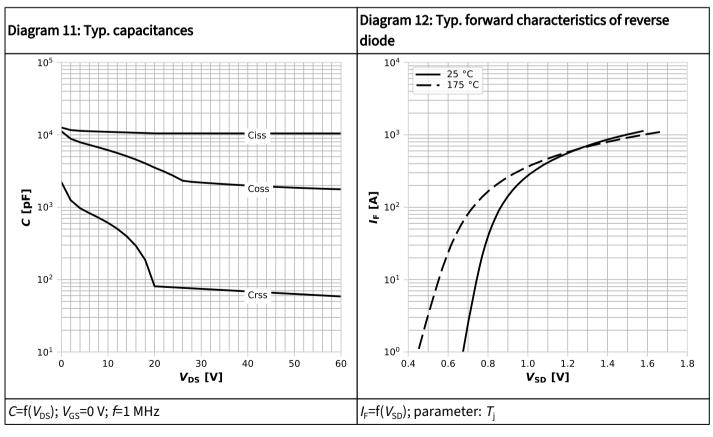




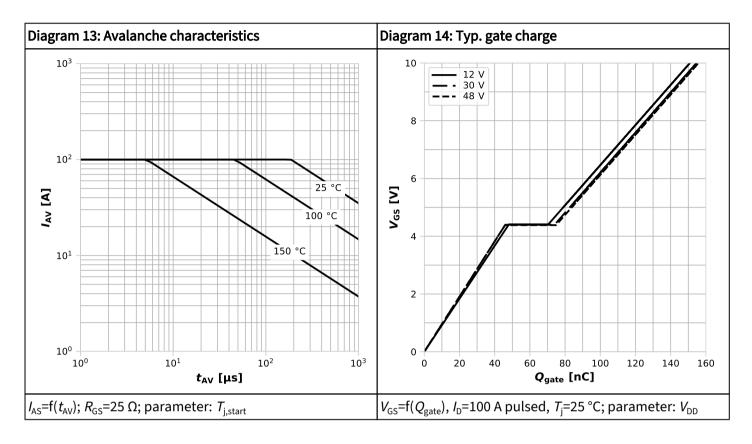


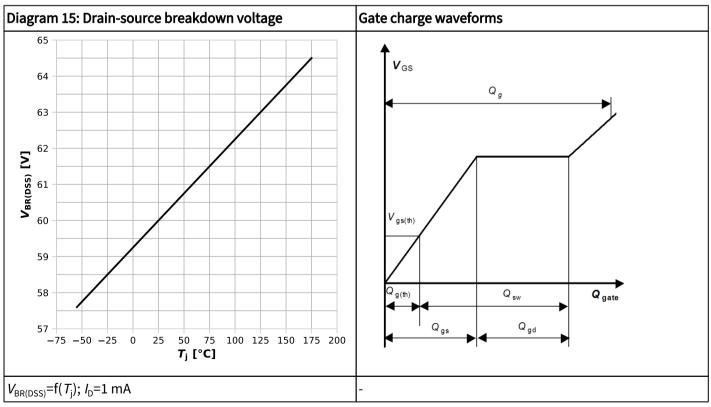






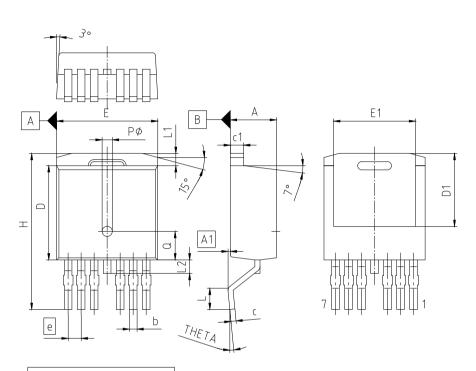








## 5 Package Outlines



PACKAGE - GROUP NUMBER:	PG-TO263-7-U02						
DIMENSIONS	MILLIN	IETERS					
DIMENSIONS	MIN.	MAX.					
Α	4.30	4.70					
A1	0.00	0.25					
b	0.65	0.85					
С	0.45	0.60					
c1	1.25	1.40					
D	9.00	9.40					
D1	6.86	7.42					
E	9.68	10.08					
E1	7.70	8.30					
е	1.27						
N		7					
Н	14.61	15.88					
L	1.78	2.79					
L1	0.00	1.60					
L2	0.00	1.78					
THETA	0° - 8°						
PØ	0.90	1.10					
Q	2.	78					

Figure 1 Outline PG-TO263-7, dimensions in mm



### **Revision History**

IPF012N06NF2S

#### Revision 2024-10-07, Rev. 2.1

#### **Previous Revision**

Revision	Date	Subjects (major changes since last revision)
2.0	2022-10-17	Release of final version
2.1	2024-10-07	Added trr and Qrr at diF/dt=100 A/μs

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